

Search Notes

Application/Control No.

10/758,171

Examiner

/BINH K. TIEU/

Applicant(s)/Patent under
Reexamination

SHANKAR ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	1.01	12/24/2007	BKT
↓	9	↓	↓
	10.01		
	10.02		
	12-13		
	15.01		
	16-18		
	22-22.01		
	29.01		
	32.01		
↓	33		
370	352-356	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST DATABASES SERACH	12/23/2007	BKT
WEST DATABASES SERACH	12/25/2007	BKT